Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	••
09/868,171	LAIER ET AL.	
Examiner	Art Unit	
Jason T. Whinkey	2622	

	SEAR	CHED	
Class	Subclass	Date	Examiner
	4,		

INT	ERFERENC	E SEARCI	HED
Class	Subclass	Date	Examiner

SEAI (INCLUDING S	RCH NOTES SEARCH STRATEGY	·)
	DATE	EXMR
Text search	4/2/2006	JTW
<u>.</u> .		
10000		